

Notice of References Cited	Application/Control No. 10/507,192		Applicant(s)/Patent Under Reexamination KWONG, KAM CHOON	
	Examiner Hieu P. Nguyen		Art Unit 2817	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0020227	01-2005	Kumagawa et al.	455/234.1
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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FOREIGN PATENT DOCUMENTS

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